System testing of Sumitomo 1300nm module

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Mark Nowell
Hewlett-Packard Laboratories
mn@hplb.hpl.hp.com

Paul Pace
Sumitomo Electric

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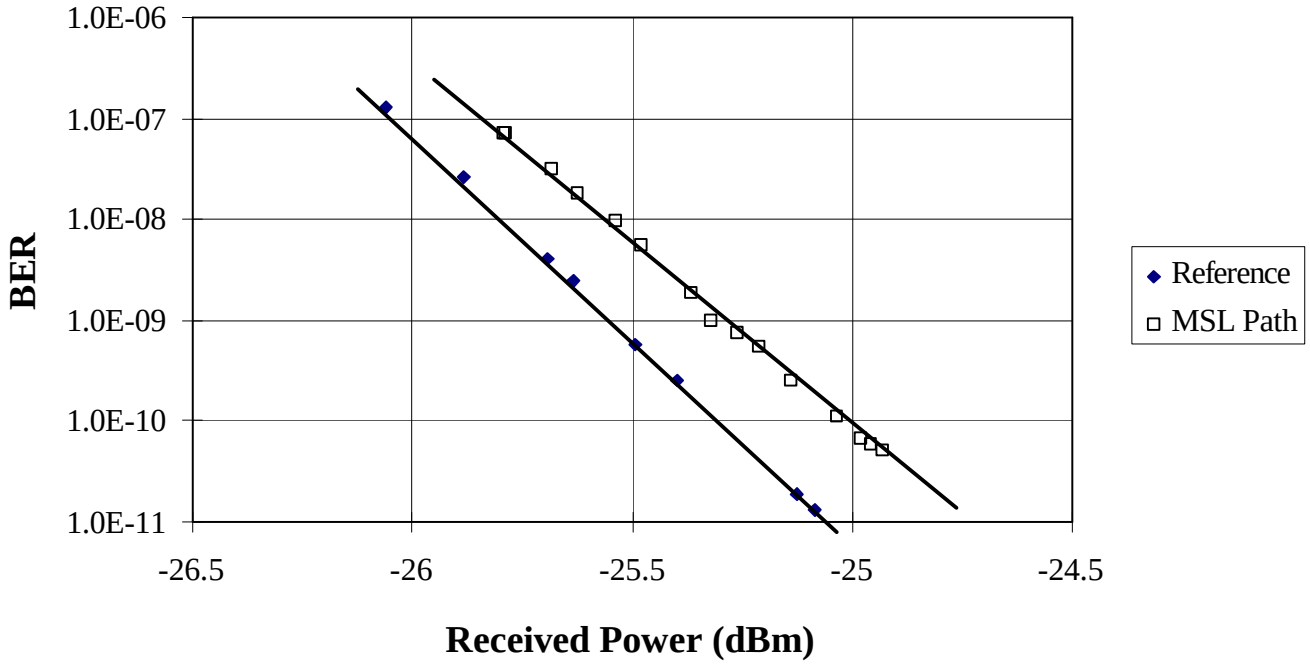
Modal noise testing

1.25 Gb/s, 2^7-1 PRBS, 50MMF



Tested using current MNMTG draft procedure

Modal noise penalty = 0.3dB

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Power penalty - simulated dirty connector

- used same testing configuration presented in earlier talk ('Effects of dirty connectors...')
- 'dirt' was a 250µm diameter wire which was moved through the beam at image plane (equivalent to 5µm line in real connector)
- penalty was measured at different positions of wire using Sumitomo 1300nm FP laser

Max Loss (dB)		Max Penalty (dB)
1300nm OFL	**1300nm RML**	**1300nm**
1.2	2.6	1.9

Only a penalty.
Not a floor.

As with all other system measurements, fiber shaking and temperature ramping were used to induced modal noise if present.